

PCB Test Sharp Tip Test Probe SF-PA100-B

Material and finishes

Plunger: Bronze or Brass or BeCu, gold plated or nickel plated;

Barrel: Brass, Gold plated or Nickel plated;

Spring: Stainless steel or Music wire;

Pictures

- Any tips, we could provide for you
- If you are interested in it, pls contact me



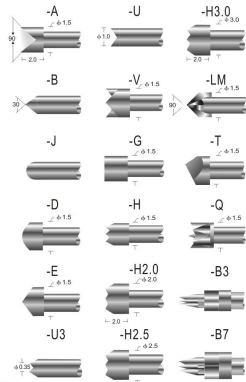
SF-P100



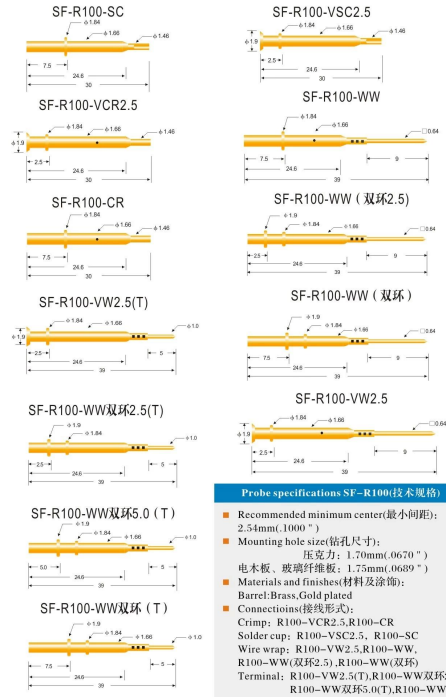
SF-P100-E

Probe specifications SF-P100(技术规格)

- Recommended minimum center(最小间距): 2.54mm(.1000")
- Mounting hole size(钻孔尺寸): 压克力: 1.70mm(.0670") 电木板、玻璃纤维板: 1.75mm(.0689")
- Full travel(行程): 6.40(.2520")
- Spring force(弹簧压力): 200g
- Materials and finishes(材料及涂饰): Plunger: Be Cu, Rh plated; SK4, Rh plated Barrel: Brass, Gold plated Spring: Stainless steel
- Current rating(额定电流): 3A(安培)
- Contact resistance(接触电阻): 50mΩ(毫欧姆)



SF-R100



Probe specifications SF-R100(技术规格)

- Recommended minimum center(最小间距): 2.54mm(.1000")
- Mounting hole size(钻孔尺寸): 压克力: 1.70mm(.0670") 电木板、玻璃纤维板: 1.75mm(.0689")
- Materials and finishes(材料及涂饰): Barrel: Brass, Gold plated
- Connections(接线形式): Crimp: R100-VCR2.5, R100-CR Solder cup: R100-VSC2.5, R100-SC Wire wrap: R100-VW2.5, R100-WW, R100-WW(双环2.5), R100-WW(双环)
- Terminal: R100-VW2.5(T), R100-WW双环2.5(T), R100-WW双环5.0(T), R100-WW双环(T)

Our Advantages

1. we have 30 years experience in probe pin and have ourself factory.
2. we provide free sample and have a testing department.
3. we could manufacture products as your request.
4. we guarantee best price and good service.

Our Main Product

Spring loaded pin (single) for PCB, ICT, FCT testing etc;
Pogo pin (connector) to establish connection between two printed circuit boards for charging, locating, Battery, Semiconductor & Interconnect applications;
Double ended probe for BGA and Semiconductor testing;
Universal pin without spring, coating pin, LM pin with QZ and VZ series;
High current probe, Switch probe, Capacitance needle;
Terminal & receptacle /socket;
Other related electronic components, 30# OK wire, Jig locks, POM, Iron hinge etc

Testing Equipment Control

| | | |
|--|--|---|
| Spring exhausted tester | DC power supply | Current resistance tester |
|  |  |  |
| Microscope | Tensile strength tester | Spring tester |
|  |  |  |

Package

